

Search Notes

Application/Control No.

10/766,177

Examiner

Russell Frejd

Applicant(s)/Patent under
Reexamination

CHEN ET AL.

Art Unit

2128

SEARCHED

Class	Subclass	Date	Examiner
703	1, 2	9.14.06	RF
1	6, 7		
345	420		
1	423		
700	97, 98		
1	182		
156	212		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST SCIENCE DIRECT ACM DIG. LIB.	9.14.06	RF
IEEE Xplore		